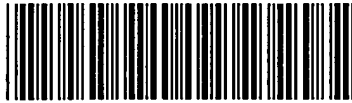


Search Notes

Application/Control No.

10/769,115

Examiner

Emily Y. Chan

Applicant(s)/Patent under
Reexamination

KWARK, YOUNG HOON

Art Unit

2829

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
324/750-765;702;356;250/492.2 (text searched only-see history printout)	8/11/2005	EC
Inventorship and EAST for class 324 (text searched only-see history printout)	12/18/2005	EC